

# Simple lower-bounds for small-bias spaces

Preetum Nakkiran

Jun 03, 2016

I was reading about PRGs recently, and I think a lemma mentioned last time (used for Johnson-Lindenstrauss lower-bounds) can give simple lower-bounds for  $\varepsilon$ -biased spaces.

Notice:

- $2^n$  mutually orthogonal vectors requires dimension at least  $2^n$ , but  $2^n$  “almost orthogonal” vectors with pairwise inner-products  $|\langle v_i, v_j \rangle| \leq \varepsilon$  exists in dimension  $O(n/\varepsilon^2)$ , by Johnson-Lindenstrauss.
- Sampling  $n$  iid uniform bits requires a sample space of size  $2^n$ , but  $n$   $\varepsilon$ -biased bits can be sampled from a space of size  $O(n/\varepsilon^2)$ .

First, let’s look at  $k$ -wise independent sample spaces, and see how the lower-bounds might be extended to the almost  $k$ -wise independent case.

*Note: To skip the background, just see Lemma 2, and its application in Claim 4.*

## 1 Preliminaries

What “size of the sample space” means is: For some sample space  $S$ , and  $\pm 1$  random variables  $X_i$ , we will generate bits  $x_1, \dots, x_n$  as an instance of the r.vs  $X_i$ . That is, by drawing a sample  $s \in S$ , and setting  $x_i = X_i(s)$ . We would like to have  $|S| \ll 2^n$ , so we can sample from it using less than  $n$  bits.

Also, any random variable  $X$  over  $S$  can be considered as a vector  $\tilde{X} \in \mathbb{R}^{|S|}$ , with coordinates  $\tilde{X}[s] := \sqrt{\Pr[s]}X(s)$ . This is convenient because  $\langle \tilde{X}, \tilde{Y} \rangle = \mathbb{E}[XY]$ .

## 2 Exact $k$ -wise independence

A distribution  $D$  on  $n$  bits is  *$k$ -wise independent* if any subset of  $k$  bits are iid uniformly distributed. Equivalently, the distribution  $D : \{\pm 1\}^n \rightarrow \mathbb{R}_{\geq 0}$  is  $k$ -wise independent iff the Fourier coefficients  $\hat{D}(S) = 0$  for all  $S \neq \emptyset, |S| \leq k$ .

$n$  such  $k$ -wise independent bits can be generated from a seed of length  $O(k \log n)$  bits, using say Reed-Solomon codes. That is, the size of the sample space is  $n^{O(k)}$ . This size is optimal, as the below claim shows (adapted from Umesh Vazirani’s lecture notes [Vaz99]).

**Claim 1.** *Let  $D$  be a  $k$ -wise independent distribution on  $\{\pm 1\}$  random variables  $x_1, \dots, x_n$ , over a sample space  $S$ . Then,  $|S| = \Omega_k(n^{k/2})$ .*

*Proof.* For subset  $T \subseteq [n]$ , let  $\chi_T(x) = \prod_{i \in T} x_i$  be the corresponding Fourier character. Consider these characters as vectors in  $\mathbb{R}^{|S|}$  as described above, with

$$\langle \chi_A, \chi_B \rangle = \mathbb{E}_{x \sim D} [\chi_A(x) \chi_B(x)]$$

Let  $J$  be the family of all subsets of size  $\leq k/2$ . Note that, for  $A, B \in J$ , the characters  $\chi_A, \chi_B$  are orthogonal:

$$\begin{aligned}
\langle \chi_A, \chi_B \rangle &= \mathbb{E}_{x \sim D} [\chi_A(x) \chi_B(x)] \\
&= \mathbb{E}_{x \sim D} \left[ \left( \prod_{i \in A \cap B} x_i^2 \right) \left( \prod_{i \in A \Delta B} x_i \right) \right] \\
&= \mathbb{E}_{x \sim D} [\chi_{A \Delta B}(x)] && \text{(since } x_i^2 = 1\text{)} \\
&= 0 && \text{(since } |A \Delta B| \leq k, \text{ and } D \text{ is } k\text{-wise independent)}
\end{aligned}$$

Here  $A \Delta B$  denotes symmetric difference, and the last equality is because  $\chi_{A \Delta B}$  depends on  $\leq k$  variables, so the expectation over  $D$  is the same as over iid uniform bits.

Thus, the characters  $\{\chi_A\}_{A \in J}$  form a set of  $|J|$  mutually-orthogonal vectors in  $\mathbb{R}^{|S|}$ . So we must have  $|S| \geq |J| = \Omega_k(n^{k/2})$ . ■

The key observation was relating independence of random variables to linear independence (orthogonality). Similarly, we could try to relate  $\varepsilon$ -almost  $k$ -wise independent random variables to almost-orthogonal vectors.

### 3 Main Lemma

This result is Theorem 9.3 from Alon’s paper [Alo03]. The proof is very clean, and Section 9 can be read independently.<sup>1</sup>

**Lemma 2.** *Let  $\{v_i\}_{i \in [N]}$  be a collection of  $N$  unit vectors in  $\mathbb{R}^d$ , such that  $|\langle v_i, v_j \rangle| \leq \varepsilon$  for all  $i \neq j$ . Then, for  $\frac{1}{\sqrt{N}} \leq \varepsilon \leq 1/2$ ,*

$$d \geq \Omega\left(\frac{\log N}{\varepsilon^2 \log(1/\varepsilon)}\right)$$

This lower-bound on the dimension of “almost-orthogonal” vectors translates to a nearly-tight lower-bound on Johnson-Lindenstrauss embedding dimension, and will also help us below.

### 4 Small bias spaces

A distribution  $D$  on  $n$  bits is  $\varepsilon$ -biased w.r.t linear tests (or just “ $\varepsilon$ -biased”) if all  $\mathbb{F}_2$ -linear tests are at most  $\varepsilon$ -biased. That is, for  $x \in \{\pm 1\}^n$ , the following holds for all subsets  $S \subseteq [n]$ :

$$\left| \mathbb{E}_{x \sim D} [\chi_S(x)] \right| = \left| \Pr_{x \sim D} [\chi_S(x) = 1] - \Pr_{x \sim D} [\chi_S(x) = -1] \right| \leq \varepsilon$$

Similarly, a distribution is  $\varepsilon$ -biased w.r.t. linear tests of size  $k$  (or “ $k$ -wise  $\varepsilon$ -biased”) if the above holds for all subsets  $S$  of size  $\leq k$ .

There exists an  $\varepsilon$ -biased space on  $n$  bits of size  $O(n/\varepsilon^2)$ : a set of  $O(n/\varepsilon^2)$  random  $n$ -bit strings will be  $\varepsilon$ -biased w.h.p. Further, explicit constructions exist that are nearly optimal: the such first construction was in [NN93], and was nicely simplified by [AGHP92] (both papers are very readable).

<sup>1</sup> Theorem 9.3 is stated in terms of lower bounding the rank of a matrix  $B \in \mathbb{R}^{N \times N}$  where  $B_{i,i} = 1$  and  $|B_{i,j}| \leq \varepsilon$ . The form stated here follows by defining  $B_{i,j} := \langle v_i, v_j \rangle$ .

These can be used to sample  $n$  bits that are  $k$ -wise  $\varepsilon$ -biased, from a space of size almost  $O(k \log(n)/\varepsilon^2)$ ; much better than the size  $\Omega(n^k)$  required for perfect  $k$ -wise independence. For example<sup>2</sup>, see [AGHP92] or the lecture notes [Vaz99].

## 4.1 Lower Bounds

The best lower bound on size of an  $\varepsilon$ -biased space on  $n$  bits seems to be  $\Omega(\frac{n}{\varepsilon^2 \log(1/\varepsilon)})$ , which is almost tight. The proofs of this in the literature (to my knowledge) work by exploiting a nice connection to error-correcting codes: Say we have a sample space  $S$  under the uniform measure. Consider the characters  $\chi_T(x)$  as vectors  $\tilde{\chi}_T \in \{\pm 1\}^{|S|}$  defined by  $\tilde{\chi}_T[s] = \chi_T(x(s))$ , similar to what we did in Section 2. The set of  $2^n$  vectors  $\{\tilde{\chi}_T\}_{T \subseteq [n]}$  defines the codewords of a linear code of length  $|S|$  and dimension  $n$ . Further, the hamming-weight of each codeword (number of  $-1$ s in each codeword, in our context), is within  $n(\frac{1}{2} \pm \varepsilon)$ , since each parity  $\chi_T$  is at most  $\varepsilon$ -biased. Thus this code has relative distance at least  $\frac{1}{2} - \varepsilon$ , and we can use sphere-packing-type bounds from coding-theory to lower-bound the codeword length  $|S|$  required to achieve such a distance. Apparently the ‘‘McEliece-Rodemich-Rumsey-Welch bound’’ works in this case; a more detailed discussion is in [AGHP92, Section 7].

We can also recover this same lower bound using Lemma 2 in a straightforward way.

**Claim 3.** *Let  $D$  be an  $\varepsilon$ -biased distribution on  $n$  bits  $x_1, \dots, x_n$ , over a sample space  $S$ . Then,*

$$|S| = \Omega\left(\frac{n}{\varepsilon^2 \log(1/\varepsilon)}\right)$$

*Proof.* Following the proof of Claim 1, consider the Fourier characters  $\chi_T(x)$  as vectors  $\tilde{\chi}_T \in \mathbb{R}^{|S|}$ , with  $\tilde{\chi}_T[s] = \sqrt{\Pr[s]} \chi_T(x(s))$ . Then, for all distinct subsets  $A, B \subseteq [n]$ , we have

$$\langle \tilde{\chi}_A, \tilde{\chi}_B \rangle = \mathbb{E}_{x \sim D} [\chi_A(x) \chi_B(x)] = \mathbb{E}_{x \sim D} [\chi_{A \Delta B}(x)]$$

Since  $D$  is  $\varepsilon$ -biased,  $|\mathbb{E}_{x \sim D} [\chi_{A \Delta B}(x)]| \leq \varepsilon$  for all  $A \neq B$ . Thus, applying Lemma 2 to the collection of  $N = 2^n$  unit vectors  $\{\tilde{\chi}_T\}_{T \subseteq [n]}$  gives the lower bound  $|S| = \Omega\left(\frac{n}{\varepsilon^2 \log(1/\varepsilon)}\right)$ . ■

This also nicely generalizes the proof of Claim 1, to give an almost-tight lower bound on spaces that are  $\varepsilon$ -biased w.r.t linear tests of size  $k$ .

**Claim 4.** *Let  $D$  be a distribution on  $n$  bits that is  $\varepsilon$ -biased w.r.t. linear tests of size  $k$ . Then, the size of the sample space is*

$$|S| = \Omega\left(\frac{k \log(n/k)}{\varepsilon^2 \log(1/\varepsilon)}\right)$$

*Proof.* As before, consider the Fourier characters  $\chi_T(x)$  as vectors  $\tilde{\chi}_T \in \mathbb{R}^{|S|}$ , with  $\tilde{\chi}_T[s] = \sqrt{\Pr[s]} \chi_T(x(s))$ . Let  $J$  be the family of all subsets  $T \subseteq [n]$  of size  $\leq k/2$ . Then, for all distinct subsets  $A, B \in J$ , we have

$$|\langle \tilde{\chi}_A, \tilde{\chi}_B \rangle| = \left| \mathbb{E}_{x \sim D} [\chi_{A \Delta B}(x)] \right| \leq \varepsilon$$

since  $|A \Delta B| \leq k$ , and  $D$  is  $\varepsilon$ -biased w.r.t such linear tests. Applying Lemma 2 to the collection of  $|J|$  unit vectors  $\{\tilde{\chi}_T\}_{T \in J}$  gives  $|S| = \Omega\left(\frac{k \log(n/k)}{\varepsilon^2 \log(1/\varepsilon)}\right)$ . ■

<sup>2</sup> This can be done by composing an  $(n, k')$  ECC with dual-distance  $k$  and an  $\varepsilon$ -biased distribution on  $k' = k \log n$  bits. Basically, use a linear construction for generating  $n$  exactly  $k$ -wise independent bits from  $k'$  iid uniform bits, but use an  $\varepsilon$ -biased distribution on  $k'$  bits as the seed instead.

Note: I couldn't find the lower bound given by Claim 4 in the literature, so please let me know if you find a bug or reference.

Also, these bounds do not directly imply nearly tight lower bounds for  $\varepsilon$ -almost  $k$ -wise independent distributions (that is, distributions s.t. their marginals on all sets of  $k$  variables are  $\varepsilon$ -close to the uniform distribution, in  $\ell_\infty$  or  $\ell_1$  norm). Essentially because of the loss in moving between closeness in Fourier domain and closeness in distributions.<sup>3</sup>

## References

- [AGHP92] Noga Alon, Oded Goldreich, Johan Håstad, and René Peralta. Simple constructions of almost  $k$ -wise independent random variables. *Random Structures & Algorithms*, 3(3):289–304, 1992. URL: <http://www.tau.ac.il/~nogaa/PDFS/agh4.pdf>.
- [Alo03] Noga Alon. Problems and results in extremal combinatorics, part i. *Discrete Math*, 273:31–53, 2003. URL: <http://www.tau.ac.il/~nogaa/PDFS/extremal1.pdf>.
- [NN93] Joseph Naor and Moni Naor. Small-bias probability spaces: Efficient constructions and applications. *SIAM journal on computing*, 22(4):838–856, 1993. URL: <http://www.wisdom.weizmann.ac.il/~naor/PAPERS/bias.pdf>.
- [Vaz99] Umesh Vazirani.  $k$ -wise independence and epsilon-biased  $k$ -wise independence. 1999. URL: <https://people.eecs.berkeley.edu/~vazirani/s99cs294/notes/lec4.pdf>.

---

<sup>3</sup> Eg,  $\varepsilon$ -biased  $\implies$   $\varepsilon$ -close in  $\ell_\infty$ , but  $\varepsilon$ -close in  $\ell_\infty$  can be up to  $2^{k-1}\varepsilon$ -biased. And  $2^{-k/2}\varepsilon$ -biased  $\implies$   $\varepsilon$ -close in  $\ell_1$ , but not the other direction.